

Notice of References Cited	Application/Control No. 10/561,516		Applicant(s)/Patent Under Reexamination GOEKE ET AL.	
	Examiner Ryan Stroncz		Art Unit 2425	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2005/0050339	03-2005	Himmel et al.	713/189
*	C	US-2004/0252247	12-2004	Wabiszczewicz, Zbigniew	348/734
*	D	US-6,035,037	03-2000	Chaney, John William	380/227
*	E	US-6,972,680	12-2005	Yui et al.	340/540
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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